

Search Notes

Application No.

10/020,449

Examiner

Y. J. Han

Applicant(s)

MIHAI ET AL.

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
363	41		
	50		
	52		
	53		
	56.12		
	141	4/04	gjt

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner